

# MOS FIELD EFFECT TRANSISTOR

# $\mu$ PA606T

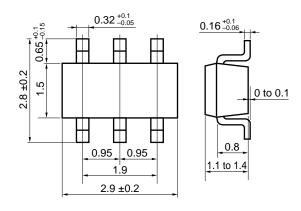
# N-CHANNEL MOS FET (6-PIN 2 CIRCUITS) FOR SWITCHING

The  $\mu$ PA606T is a mini-mold device provided with two MOS FET elements. It achieves high-density mounting and saves mounting costs.

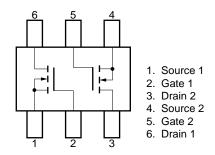
#### **FEATURES**

- Two MOS FET elements in package the same size as SC-59
- Complement to μPA607T
- · Automatic mounting supported

### PACKAGE DIMENSIONS (in millimeters)



#### PIN CONNECTION



## ABSOLUTE MAXIMUM RATINGS (TA = 25 °C)

PARAMETER	SYMBOL	RATINGS	UNIT	
Drain to Source Voltage	VDSS	50	V	
Gate to Source Voltage	Vgss	±20	V	
Drain Current (DC)	I <sub>D(DC)</sub>	100	mA	
Drain Current (pulse)	I <sub>D(pulse)</sub> *	200	mA	
Total Power Dissipation	Рт	300 (Total)	mW	
Channel Temperature	Tch	150	°C	
Storage Temperature	T <sub>stg</sub>	-55 to +150	°C	

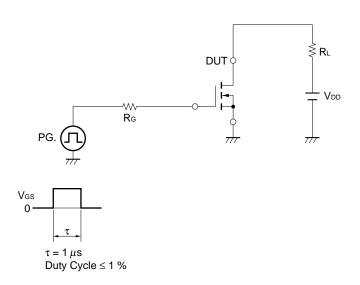
\* PW  $\leq$  10 ms, Duty Cycle  $\leq$  50 %

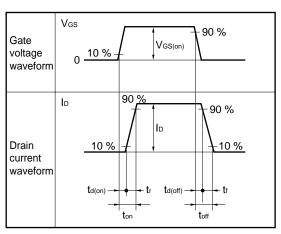


## ELECTRICAL CHARACTERISTICS (TA = 25 °C)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Drain Cut-off Current	Ipss	V <sub>DS</sub> = 50 V, V <sub>GS</sub> = 0	-	-	1.0	μΑ
Gate Leakage Current	Igss	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0$	-	-	±1.0	μΑ
Gate Cut-off Voltage	V <sub>GS(off)</sub>	$V_{DS} = 5.0 \text{ V}, \text{ Id} = 1.0 \ \mu\text{A}$	0.8	1.4	1.8	V
Forward Transfer Admittance	y <sub>fs</sub>	V <sub>DS</sub> = 5.0 V, I <sub>D</sub> = 10 mA	20	-	-	mS
Drain to Source On-State Resistance	RDS(on)1	V <sub>G</sub> S = 4.0 V, I <sub>D</sub> = 10 mA	-	19	30	Ω
Drain to Source On-State Resistance	RDS(on)2	V <sub>G</sub> S = 10 V, I <sub>D</sub> = 10 mA	-	15	25	Ω
Input Capacitance	Ciss	V <sub>DS</sub> = 5.0 V, V <sub>GS</sub> = 0, f = 1.0 MHz	ı	16	-	pF
Output Capacitance	Coss		-	12	-	pF
Reverse Transfer Capacitance	Crss		-	3	-	pF
Turn-On Delay Time	td(on)	$V_{GS(on)} = 5.0 \text{ V, } R_G = 10 \Omega, \text{ V}_{DD} = 5.0 \text{ V,}$ $I_D = 10 \text{ mA, } R_L = 500 \Omega$	-	17	-	ns
Rise Time	tr		-	10	-	ns
Turn-Off Delay Time	td(off)		_	68	-	ns
Fall Time	<b>t</b> f		_	38	-	ns

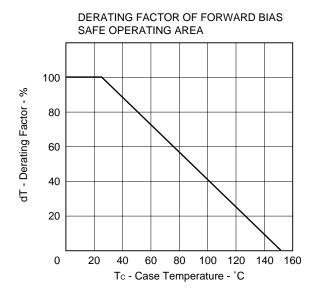
## SWITCHING TIME MEASUREMENT CIRCUIT AND CONDITIONS (RESISTANCE LOADED)

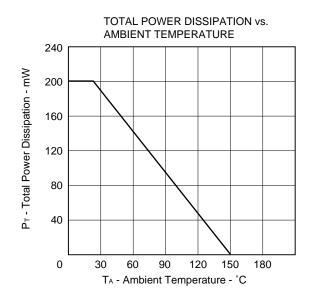


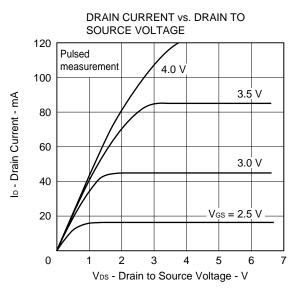


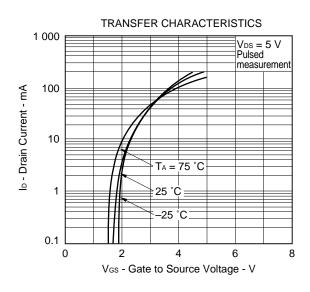


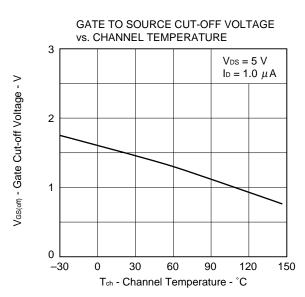
### TYPICAL CHARACTERISTICS (TA = 25 °C)

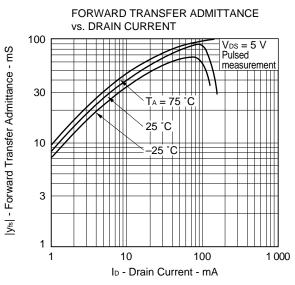




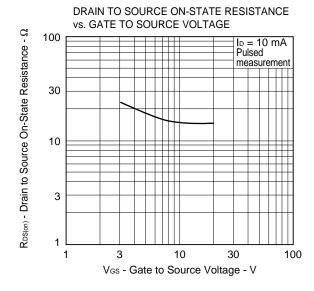


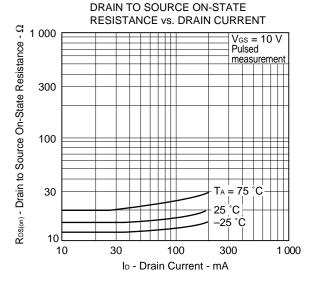


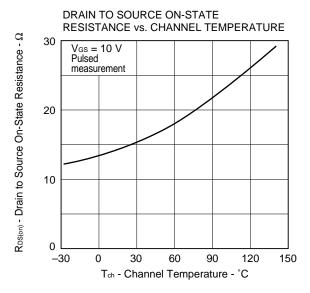


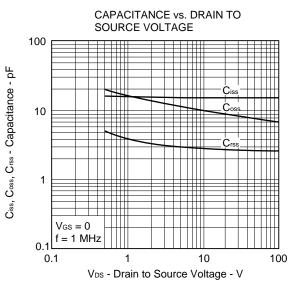


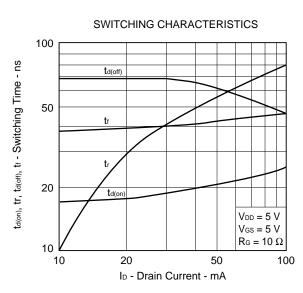


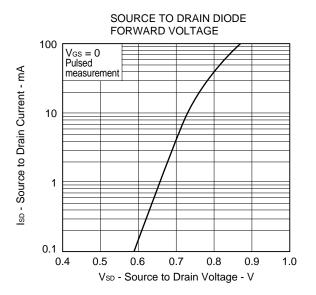














## **REFERENCE**

Document Name	Document No.		
NEC semiconductor device reliability/quality control system	TEI-1202		
Quality grade on NEC semiconductor devices	IEI-1209		
Semiconductor device mounting technology manual	C10535E		
Guide to quality assurance for semiconductor devices	MEI-1202		
Semiconductor selection guide	X10679E		

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Anti-radioactive design is not implemented in this product.

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